## Notice of References Cited Application/Control No. 10/706,231 Examiner Kyung Hye Shin Applicant(s)/Patent Under Reexamination HARIHARAN ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-5,870,561 A	02-1999	Jarvis et al.	709/238	
*	В	US-6,134,618 A	10-2000	Hebert, Mark P.	710/105	
*	C	US-2003/0126223 A1	07-2003	Jenne et al.	709/212	
*	D	US-2003/0126280 A1	07-2003	Yao et al.	709/234	
	Е	US-				
	F	US-				
	G	US-				
	Н	US-				
	1	US-				
	J	US-				
	K	US-				
	L	US-				
	М	US-				

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.